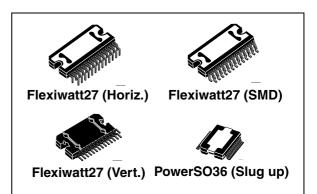


TDA7563A

4 x 50 W power amplifier with full I²C diagnostics, high efficiency and low voltage operation Datasheet – production data

Features

- Multipower BCD technology
- MOSFET output power stage
- DMOS power output
- New high efficiency (class SB)
- High output power capability 4 x 28 W / 4 Ω @ 14.4 V, 1 kHz, 10 % THD, 4 x 50 W max power
- Max. output power 4 x 72 W / 2 Ω
- Full I^2C bus driving:
 - Standby
 - Independent front/rear soft play/mute
 - Selectable gain 26 dB /12 dB (for low noise line output function)
 - High efficiency enable/disable
 - I²C bus digital diagnostics (including DC and AC load detection)
- Full fault protection
- DC offset detection
- Four independent short circuit protection
- Clipping detector pin with selectable threshold (2 %/10 %)
- Standby/mute pin
- Linear thermal shutdown with multiple thermal warning
- ESD protection



Description

The TDA7563A is a new BCD technology Quad Bridge type of car radio amplifier in Flexiwatt27 & PowerSO36 packages specially intended for car radio applications.

Thanks to the DMOS output stage the TDA7563A has a very low distortion allowing a clear powerful sound. Among the features, its superior efficiency performance coming from the internal exclusive structure, makes it the most suitable device to simplify the thermal management in high power sets.

The dissipated output power under average listening condition is in fact reduced up to 50% when compared to the level provided by conventional class AB solutions.

This device is equipped with a full diagnostics array that communicates the status of each speaker through the I^2C bus.

Order code	Package	Packing
TDA7563A	Flexiwatt27 (vertical)	Tube
TDA7563AH	Flexiwatt27 (horizontal)	Tube
TDA7563ASM	Flexiwatt27 (SMD)	Tube
TDA7563ASMTR	Flexiwatt27 (SMD)	Tape and reel
TDA7563APD	PowerSO36 (slug up)	Tube

Table 1. Device summary

August 2012

Doc ID 14407 Rev 2

This is information on a product in full production.

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1 Block, pins connection and application diagrams

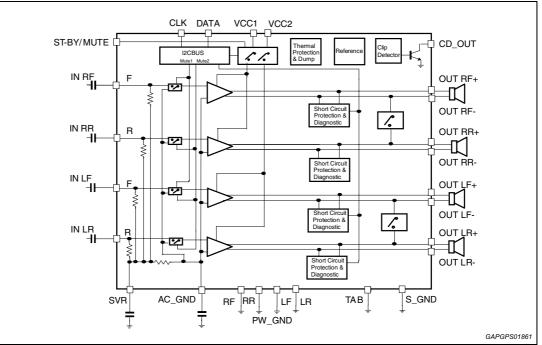
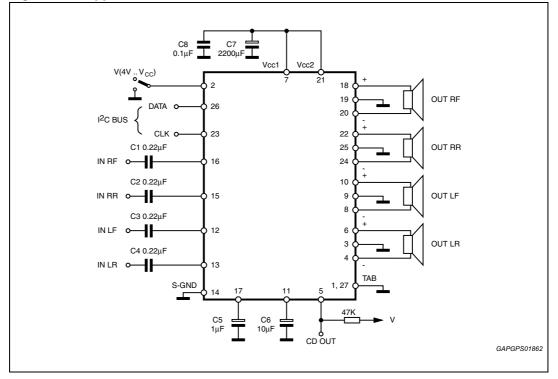
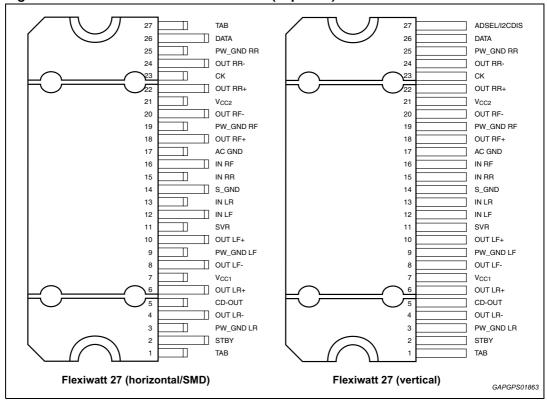


Figure 1. Block diagram

Figure 2. Application circuit

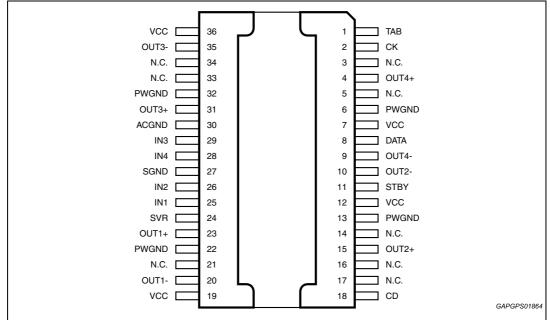


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2 Electrical specifications

2.1 Absolute maximum ratings

Table 2.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V _{op}	Operating supply voltage	18	V
V _S	DC supply voltage	28	V
V _{peak}	Peak supply voltage (for t = 50 ms)	50	V
V _{CK}	CK pin voltage	6	V
V _{DATA}	Data pin voltage	6	V
Ι _Ο	Output peak current (not repetitive t = 100 ms)	8	А
Ι _Ο	Output peak current (repetitive f > 10 Hz)	6	А
P _{tot}	Power dissipation T _{case} = 70 °C	85	W
T _{stg} , T _j	Storage and junction temperature	-55 to 150	°C

2.2 Thermal data

Table 3. Thermal data

Symbol	Parameter		PowerSO36	Flexiwatt 27	Unit
R _{th j-case}	Thermal resistance junction-to-case	Мах	1	1	°C/W

2.3 Electrical characteristics

Refer to the test circuit, $V_S = 14.4 \text{ V}$; f = 1 kHz; $R_L = 4 \Omega$; $T_{amb} = 25 \text{ °C}$ unless otherwise specified.

Table 4.Electrical characteristics

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
Power amplifier						
Vs	Supply voltage range	-	8	-	18	V
۱ _d	Total quiescent drain current	-	-	170	300	mA
		Max. power (V _S = 15.2 V, square wave input (2-Vrms))	-	50	-	W
		THD = 10-% THD = 1-%	25 20	28 22	-	W W
P _O	Output power	$R_L = 2-\Omega$; EIAJ (V _S = 13.7-V) $R_L = 2-\Omega$; THD 10-% $R_L = 2-\Omega$; THD 1-% $R_L = 2-\Omega$; max power	55 40 32 60	68 50 40 75	-	W W W W



Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
		P _O = 1 to 10 W; STD MODE		0.015	0.1	%
		HE MODE; $P_0 = 1.5 W$	-	0.01	0.1	%
		HE MODE; P _O = 8 W		0.1	0.5	%
THD	Total harmonic distortion	P _O = 1-10 W, f = 10kHz; STD mode	-	0.15	0.5	%
		$R_L = 2\Omega$; HE MODE; Po = 3W	-	0.02	0.5	%
		G_V = 12 dB; STD mode V _O = 0.1 to 5 V _{RMS}	-	0.015	0.1	%
CT	Cross talk	f = 1 kHz to 10 kHz, R_g = 600 Ω	50	60	-	dB
R _{IN}	Input impedance	-	60	100	130	KΩ
G _{V1}	Voltage gain 1 (default)	-	25	26	27	dB
ΔG_{V1}	Voltage gain match 1	-	-1		1	dB
G _{V2}	Voltage gain 2	-	11	12	13	dB
ΔG_{V2}	Voltage gain match 2	-	-1	-	1	dB
E _{IN1}	Output noise voltage 1	Rg = 600 Ω; filter 20 Hz to 22 kHz	-	35	-	μV
E _{IN2}	Output noise voltage 2	Rg = 600 Ω; G_V = 12 dB filter 20 Hz to 22 kHz	-	11	-	μV
SVR	Supply voltage rejection	f = 100 Hz to 10 kHz; V _r = 1 Vpk; R _g = 600 Ω	50	70	-	dB
BW	Power bandwidth	-	100	-	-	kHz
A_{SB}	Standby attenuation	-	90	110		dB
I _{SB}	Standby current	V _{standby} = 0	-	1	10	μA
A _M	Mute attenuation	-	80	100		dB
V _{OS}	Offset voltage	Mute & Play	-60	0	60	mV
V _{AM}	Min. supply mute threshold	-	7	7.5	8	V
T _{ON}	Turn on delay	D2/D1 (IB1) 0 to 1	-	5	20	ms
T _{OFF}	Turn off delay	D2/D1 (IB1) 1 to 0	-	5	20	ms
V _{SBY}	Standby/mute pin for standby	-	0	-	1.5	V
V _{MU}	Standby/mute pin for mute	-	3.5	-	5	V
CMRR	Input CMRR	V_{CM} = 1 Vpk-pk; Rg = 0 Ω	-	55	-	dB
V _{OP}	Standby/mute pin for operating		7	-	VS	V
		V _{standby/mute} = 8.5 V	-	20	40	μA
I _{MU}	Standby/mute pin current	V _{standby/mute} < 1.5 V	-	0	5	μA
CD _{LK}	Clip det. high leakage current	CD off / $V_{CD} = 6 V$	-	0	5	μA
CD _{SAT}	Clip det. saturation voltage	CD on; I _{CD} = 1 mA	-	-	300	mV
		D0 (IB1) = 1	5	10	15	%
CD _{THD}	Clip det. THD level	D0 (IB1) = 0	1	2	3	%

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Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
Turn on c	diagnostics 1 (Power amplifier r	node)				
Pgnd	Short to GND det. (below this limit, the output is considered in short circuit to GND)		-	-	1.2	v
Pvs	Short to Vs det. (above this limit, the output is considered in short circuit to VS)		Vs -1.2	-	-	v
Pnop	Normal operation thresholds. (within these limits, the output is considered without faults).	Power amplifier in standby	1.8	-	Vs -1.8	v
Lsc	Shorted load det.		-	-	0.5	Ω
Lop	Open load det.		130	-	-	Ω
Lnop	Normal load det.		1.5	-	70	Ω
Turn on o	diagnosticS 2 (Line driver mode	.)				
Pgnd	Short to GND det. (below this limit, the output is considered in short circuit to GND)	Power amplifier in standby	-	-	1.2	V
Pvs	Short to Vs det. (above this limit, the output is considered in short circuit to VS)	-	Vs -1.2	-	-	V
Pnop	Normal operation thresholds. (within these limits, the output is considered without faults).	-	1.8	-	Vs -1.8	V
Lsc	Shorted load det.	-		-	1.5	Ω
Lop	Open load det.	-	400	-	-	Ω
Lnop	Normal load det.	-	4.5	-	200	Ω
Permane	nt diagnostics 2 (Power amplifi	er mode or line driver mode)				
Pgnd	Short to GND det. (below this limit, the output is considered in short circuit to GND)		-	-	1.2	V
Pvs	Short to Vs det. (above this limit, the output is considered in short circuit to Vs)	Power amplifier in mute or play, one or more short circuits protection activated	Vs -1.2	-	-	v
Pnop	Normal operation thresholds. (within these limits, the output is considered without faults).		1.8	-	Vs -1.8	v
1	Shorted load det.	Power amplifier mode	-	-	0.5	Ω
L _{SC}	טוטונפט וטמט עפו.	Line driver mode	-	-	1.5	Ω
V _O	Offset detection	Power amplifier in play, STD mode AC input signals = 0	±1.5	±2	±2.5	V

Table 4. Electrical characteristics (continued)



Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
I _{NL}	Normal load current detection	V _O < (V _S -5)pk	500	-	-	mA
I _{OL}	Open load current detection		-	-	250	mA
I ² C bus interface						
S _{CL}	Clock frequency	-	-	-	400	kHz
V _{IL}	Input low voltage	-	-	-	1.5	V
V _{IH}	Input high voltage	-	2.3	-	-	V

 Table 4.
 Electrical characteristics (continued)

2.4 Electrical characteristics curves

Figure 5. Quiescent current vs. supply voltage Figure 6. Output power vs. supply voltage (4Ω)

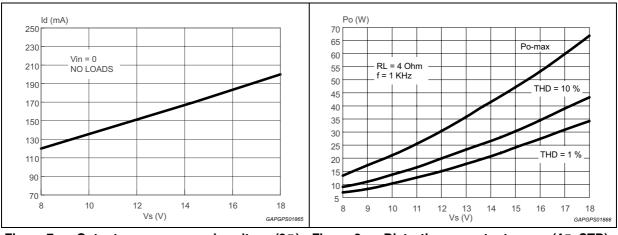
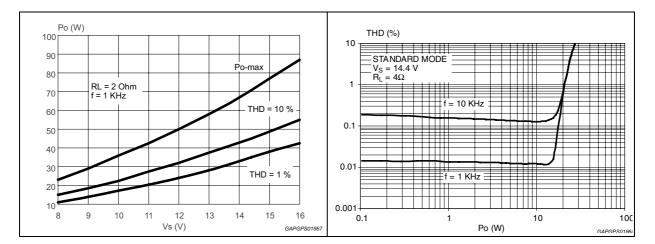


Figure 7. Output power vs. supply voltage (2 Ω) Figure 8. Distortion vs. output power (4 Ω , STD)





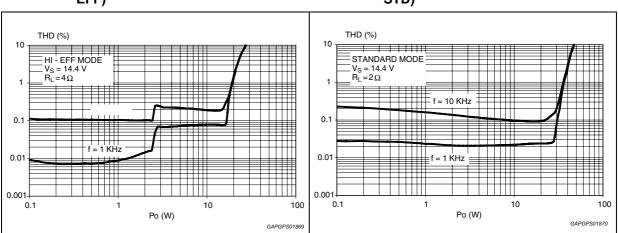
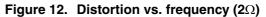


Figure 9.Distortion vs. output power (4Ω, HI-Figure 10.Distortion vs. output power (2Ω,EFF)STD)





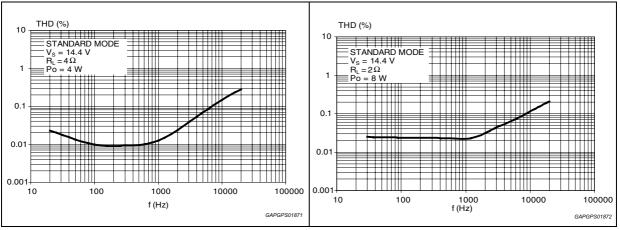




Figure 14. Supply voltage rejection vs. frequency

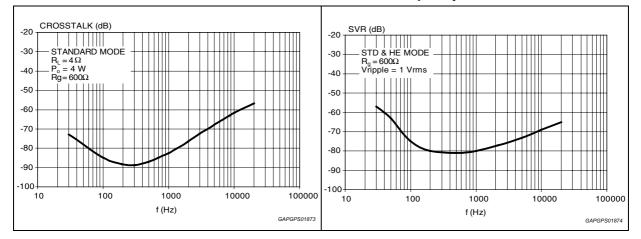




Figure 15.Power dissipation and efficiency vs.Figure 16.Power dissipation and efficiency vs.output power (4Ω , STD, SINE)output power (4Ω , HI-EFF, SINE)

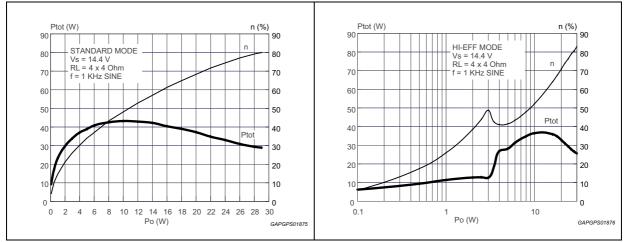
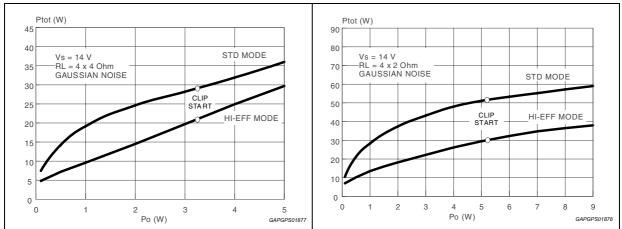


Figure 17. Power dissipation vs. average output power (audio program simulation, 4Ω)

Figure 18. Power dissipation vs. average output power (audio program simulation, 2Ω)





3 Diagnostics functional description

3.1 Turn-on diagnostic

It is activated at the turn-on (standby out) under I²C bus request. Detectable output faults are:

- SHORT TO GND
- SHORT TO Vs
- SHORT ACROSS THE SPEAKER
- OPEN SPEAKER

To verify if any of the above misconnections are in place, a subsonic (inaudible) current pulse (*Figure 19*) is internally generated, sent through the speaker(s) and sunk back. The Turn On diagnostic status is internally stored until a successive diagnostic pulse is requested (after a I^2C reading).

If the "standby out" and "diagnostic enable" commands are both given through a single programming step, the pulse takes place first (power stage still in standby mode, low, outputs = high impedance).

Afterwards, when the amplifier is biased, the PERMANENT diagnostic takes place. The previous Turn On state is kept until a short appears at the outputs.

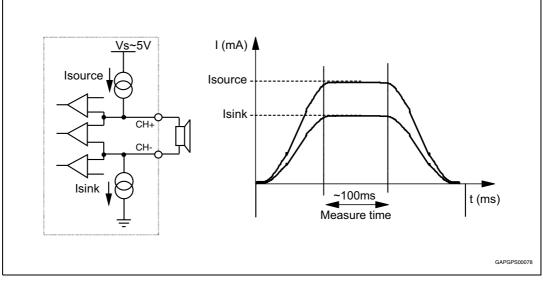


Figure 19. Turn-on diagnostic: working principle

Figure 20 and *21* show SVR and OUTPUT waveforms at the turn-on (standby out) with and without TURN-ON DIAGNOSTIC.



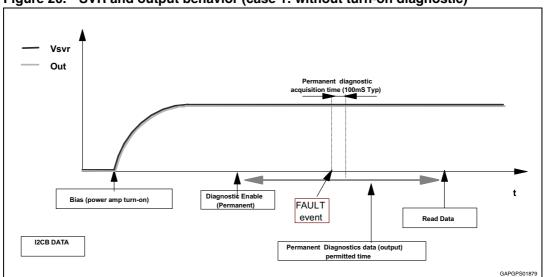
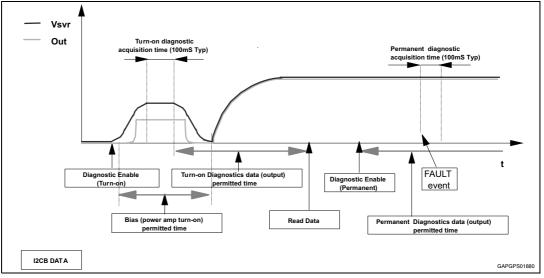


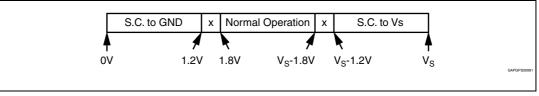
Figure 20. SVR and output behavior (case 1: without turn-on diagnostic)

Figure 21. SVR and output pin behavior (case 2: with turn-on diagnostic)



The information related to the outputs status is read and memorized at the end of the current pulse top. The acquisition time is 100 ms (typ.). No audible noise is generated in the process. As for SHORT TO GND / V_S the fault-detection thresholds remain unchanged from 26 dB to 12 dB gain setting. They are as follows:TDA7563A

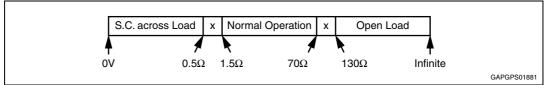
Figure 22. Thresholds for short to GND/V_S





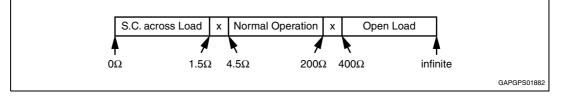
Concerning SHORT ACROSS THE SPEAKER / OPEN SPEAKER, the threshold varies from 26 dB to 12 dB gain setting, since different loads are expected (either normal speaker's impedance or high impedance). The values in case of 26 dB gain are as follows:

Figure 23. Thresholds for short across the speaker/open speaker



If the Line-Driver mode (Gv= 12 dB and Line Driver Mode diagnostic = 1) is selected, the same thresholds will change as follows:

Figure 24. Thresholds for line-drivers



3.2 Permanent diagnostics

Detectable conventional faults are:

- Short to GND
- Short to Vs
- Short across the speaker
- The following additional features are provided:
 - Output offset detection

The TDA7563A has 2 operating statuses:

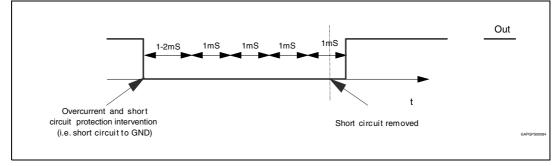
- 1. RESTART mode. The diagnostic is not enabled. Each audio channel operates independently from each other. If any of the a.m. faults occurs, only the channel(s) interested is shut down. A check of the output status is made every 1 ms (*Figure 25*). Restart takes place when the overload is removed.
- DIAGNOSTIC mode. It is enabled via I²C bus and self activates if an output overload (such to cause the intervention of the short-circuit protection) occurs to the speakers outputs. Once activated, the diagnostics procedure develops as follows (*Figure 26*):
 - To avoid momentary re-circulation spikes from giving erroneous diagnostics, a check of the output status is made after 1ms: if normal situation (no overloads) is detected, the diagnostic is not performed and the channel returns back active.
 - Instead, if an overload is detected during the check after 1 ms, then a diagnostic cycle having a duration of about 100 ms is started.
 - After a diagnostic cycle, the audio channel interested by the fault is switched to RESTART mode. The relevant data are stored inside the device and can be read by the microprocessor. When one cycle has terminated, the next one is activated

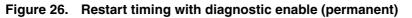


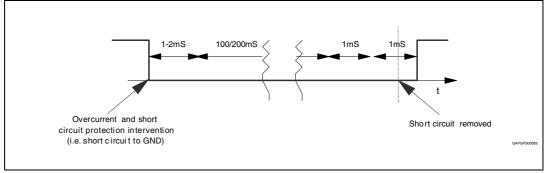
by an I²C reading. This is to ensure continuous diagnostics throughout the carradio operating time.

- To check the status of the device a sampling system is needed. The timing is chosen at microprocessor level (over half a second is recommended).

Figure 25. Restart timing without diagnostic enable (permanent) - Each 1ms time, a sampling of the fault is done









4 Output DC offset detection

Any DC output offset exceeding +/- 2 V are signalled out. This inconvenient might occur as a consequence of initially defective or aged and worn-out input capacitors feeding a DC component to the inputs, so putting the speakers at risk of overheating.

This diagnostic has to be performed with low-level output AC signal (or Vin = 0).

The test is run with selectable time duration by microprocessor (from a "start" to a "stop" command):

- START = Last reading operation or setting IB1 D5 (OFFSET enable) to 1
- STOP = Actual reading operation

Excess offset is signalled out if persistent throughout the assigned testing time. This feature is disabled if any overloads leading to activation of the short-circuit protection occurs in the process.

4.1 AC diagnostic

It is targeted at detecting accidental disconnection of tweeters in 2-way speaker and, more in general, presence of capacitively (AC) coupled loads.

This diagnostic is based on the notion that the overall speaker's impedance (woofer + parallel tweeter) will tend to increase towards high frequencies if the tweeter gets disconnected, because the remaining speaker (woofer) would be out of its operating range (high impedance). The diagnostic decision is made according to peak output current thresholds, as follows:

lout > 500mApk = NORMAL STATUS lout < 250mApk = OPEN TWEETER

To correctly implement this feature, it is necessary to briefly provide a signal tone (with the amplifier in "play") whose frequency and magnitude are such to determine an output current higher than 500mApk with in normal conditions and lower than 250mApk should the parallel tweeter be missing.

The test has to last for a minimum number of 3 sine cycles starting from the activation of the AC diagnostic function IB2<D2>) up to the I^2C reading of the results (measuring period). To confirm presence of tweeter, it is necessary to find at least 3 current pulses over 500mA over all the measuring period, else an "open tweeter" message will be issued.

The frequency / magnitude setting of the test tone depends on the impedance characteristics of each specific speaker being used, with or without the tweeter connected (to be calculated case by case). High-frequency tones (> 10 kHz) or even ultrasonic signals are recommended for their negligible acoustic impact and also to maximize the impedance module's ratio between with tweeter-on and tweeter-off.

Figure 27 shows the Load Impedance as a function of the peak output voltage and the relevant diagnostic fields.

This feature is disabled if any overloads leading to activation of the short-circuit protection occurs in the process.



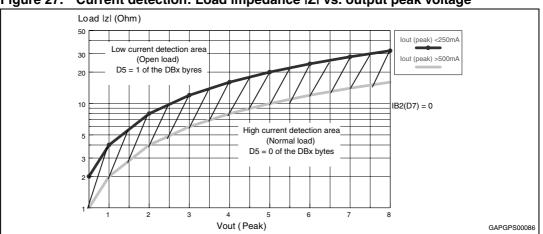


Figure 27. Current detection: Load impedance |Z| vs. output peak voltage

4.2 Multiple faults

When more misconnections are simultaneously in place at the audio outputs, it is guaranteed that at least one of them is initially read out. The others are notified after successive cycles of I^2C reading and faults removal, provided that the diagnostic is enabled. This is true for both kinds of diagnostic (Turn on and Permanent).

The table below shows all the couples of double-fault possible. It should be taken into account that a short circuit with the 4 ohm speaker unconnected is considered as double fault.

	S. GND (so)	S. GND (sk)	S. Vs	S. Across L.	Open L.	
S. GND (so)	S. GND	S. GND	S. Vs + S. GND	S. GND	S. GND	
S. GND (sk)	/	S. GND	S. Vs	S. GND	Open L. (*)	
S. Vs	/	/	S. Vs	S. Vs	S. Vs	
S. Across L.	/	/	/	S. Across L.	N.A.	
Open L.	/	/	/	/	Open L. (*)	

Table 5. Double fault table for turn on diagnostic

S. GND (so) / S. GND (sk) in the above table make a distinction according to which of the 2 outputs is shorted to ground (test-current source side= so, test-current sink side = sk). More precisely, in Channels LF and RR, so = CH+, sk = CH-; in Channels LR and RF, so = CH-, sk = CH+.

In Permanent Diagnostic the table is the same, with only a difference concerning Open Load(*), which is not among the recognizable faults. Should an Open Load be present during the device's normal working, it would be detected at a subsequent Turn on Diagnostic cycle (i.e. at the successive Car Radio Turn on).



4.3 Faults availability

All the results coming from I^2C bus, by read operations, are the consequence of measurements inside a defined period of time. If the fault is stable throughout the whole period, it will be sent out.

To guarantee always resident functions, every kind of diagnostic cycles (Turn on, Permanent, Offset) will be reactivate after any I^2C reading operation. So, when the micro reads the I^2C , a new cycle will be able to start, but the read data will come from the previous diag. cycle (i.e. The device is in Turn On state, with a short to Gnd, then the short is removed and micro reads I^2C . The short to Gnd is still present in bytes, because it is the result of the previous cycle. If another I^2C reading operation occurs, the bytes do not show the short). In general to observe a change in Diagnostic bytes, two I^2C reading operations are necessary.



5 Thermal protection

Thermal protection is implemented through thermal foldback (Figure 28).

Thermal foldback begins limiting the audio input to the amplifier stage as the junction temperatures rise above the normal operating range. This effectively limits the output power capability of the device thus reducing the temperature to acceptable levels without totally interrupting the operation of the device.

The output power will decrease to the point at which thermal equilibrium is reached. Thermal equilibrium will be reached when the reduction in output power reduces the dissipated power such that the die temperature falls below the thermal foldback threshold. Should the device cool, the audio level will increase until a new thermal equilibrium is reached or the amplifier reaches full power. Thermal foldback will reduce the audio output level in a linear manner.

Three Thermal warning are available through the I²C bus data.

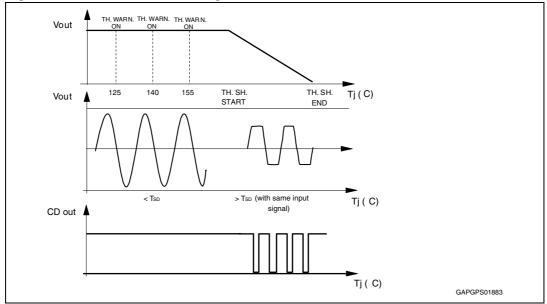


Figure 28. Thermal foldback diagram



6 Fast muting

The muting time can be shortened to less than 1.5ms by setting (IB2) D5 = 1. This option can be useful in transient battery situations (i.e. during car engine cranking) to quickly turnoff the amplifier for avoiding any audible effects caused by noise/transients being injected by preamp stages. The bit must be set back to "0" shortly after the mute transition.



7 I^2C bus

7.1 I²C programming/reading sequences

A correct turn on/off sequence respectful of the diagnostic timings and producing no audible noises could be as follows (after battery connection):

TURN-ON: PIN2 > 7V --- 10ms --- (STANDBY OUT + DIAG ENABLE) --- 500 ms (min) --- MUTING OUT

TURN-OFF: MUTING IN --- 20 ms --- (DIAG DISABLE + STANDBY IN) --- 10ms --- PIN2 = 0

Car Radio Installation: PIN2 > 7V --- 10ms DIAG ENABLE (write) --- 200 ms --- I²C read (repeat until All faults disappear).

OFFSET TEST: Device in Play (no signal) -- OFFSET ENABLE - 30ms - I²C reading (repeat I²C reading until high-offset message disappears).

7.2 I²C bus interface

Data transmission from microprocessor to the TDA7563A and vice versa takes place through the 2 wires I^2C BUS interface, consisting of the two lines SDA and SCL (pull-up resistors to positive supply voltage must be connected).

7.3 Data validity

As shown by *Figure 29*, the data on the SDA line must be stable during the high period of the clock.

The HIGH and LOW state of the data line can only change when the clock signal on the SCL line is LOW.

7.4 Start and stop conditions

As shown by *Figure 30* a start condition is a HIGH to LOW transition of the SDA line while SCL is HIGH.

The stop condition is a LOW to HIGH transition of the SDA line while SCL is HIGH.

7.5 Byte format

Every byte transferred to the SDA line must contain 8 bits. Each byte must be followed by an acknowledge bit. The MSB is transferred first.



7.6 Acknowledge

The transmitter^(*) puts a resistive HIGH level on the SDA line during the acknowledge clock pulse (see *Figure 31*). The receiver^(**) the acknowledges has to pull-down (LOW) the SDA line during the acknowledge clock pulse, so that the SDA line is stable LOW during this clock pulse.

(*) Transmitter

- master (μ P) when it writes an address to the TDA7563A
- slave (TDA7563A) when the μ P reads a data byte from TDA7563A

(**) Receiver

- slave (TDA7563A) when the μ P writes an address to the TDA7563A
- master (µP) when it reads a data byte from TDA7563A

Figure 29. Data validity on the I²C bus

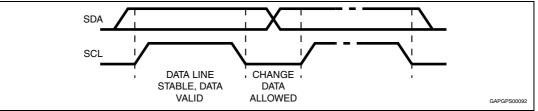


Figure 30. Timing diagram on the I^2C bus

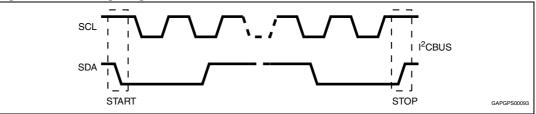
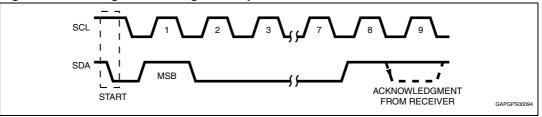


Figure 31. Timing acknowledge clock pulse





Software specifications 8

All the functions of the TDA7563A are activated by I^2C interface.

The bit 0 of the "ADDRESS BYTE" defines if the next bytes are write instruction (from μ P to TDA7563A) or read instruction (from TDA7563A to µP).

Table 6. Chip address:

D7							D0	
1	1	0	1	1	0	0	Х	D8 Hex

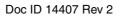
X = 0 Write to device

X = 1 Read from device

If R/W = 0, the μ P sends 2 "Instruction Bytes": IB1 and IB2.

Table 7. IB1

D7	0
D6	Diagnostic enable (D6 = 1) Diagnostic defeat (D6 = 0)
D5	Offset Detection enable (D5 = 1) Offset Detection defeat (D5 = 0)
D4	Front Channel Gain = $26dB (D4 = 0)$ Gain = $12dB (D4 = 1)$
D3	Rear Channel Gain = 26dB (D3 = 0) Gain = 12dB (D3 = 1)
D2	Mute front channels (D2 = 0) Unmute front channels (D2 = 1)
D1	Mute rear channels (D1 = 0) Unmute rear channels (D1 = 1)
D0	CD 2% (D0 = 0) CD 10% (D0 = 1)



D7	0
D6	0
D5	Normal muting time (D5 = 0) Fast muting time (D5 = 1)
D4	Standby on - Amplifier not working - (D4 = 0) Standby off - Amplifier working - (D4 = 1)
D3	Power amplifier mode diagnostic (D3 = 0) Line driver mode diagnostic (D3 = 1)
D2	Current Detection Diagnostic Enabled (D2 =1) Current Detection Diagnostic Defeat (D2 =0)
D1	Right Channel Power amplifier working in standard mode (D1 = 0) Power amplifier working in high efficiency mode (D1 = 1)
D0	Left Channel Power amplifier working in standard mode (D0 = 0) Power amplifier working in high efficiency mode (D0 = 1)

If R/W = 1, the TDA7563A sends 4 "Diagnostics Bytes" to μ P: DB1, DB2, DB3 and DB4.

Table 9.	DB1
D7	Thermal warning active (D7 = 1), $T_J = 155^{\circ}C$
D6	Diag. cycle not activated or not terminated (D6 = 0) Diag. cycle terminated (D6 = 1)
D5	Channel LF Current Detection Output peak current <250mA - Output load (D5 = 1) Output peak current >500mA - Output load (D5 = 0)
D4	Channel LF Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel LF Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel LF Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Offset diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel LF No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel LF No short to GND (D1 = 0) Short to GND (D1 = 1)



Table 10.	DB2
D7	Offset detection not activated (D7 = 0) Offset detection activated (D7 = 1)
D6	0
D5	Channel LR Current Detection Output peak current <250mA - Output load (D5 = 1) Output peak current >500mA - Output load (D5 = 0)
D4	Channel LR Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel LR Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel LR Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel LR No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel LR No short to GND (D1 = 0) Short to GND (D1 = 1)



Table 11.	DB3
D7	Standby status (= IB2 - D4)
D6	Diagnostic status (= IB1 - D6)
D5	Channel RF Current Detection Output peak current <250mA - Output load (D5 = 1) Output peak current >500mA - Output load (D5 = 0)
D4	Channel RF Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel RF Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel RF Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel RF No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel RF No short to GND (D1 = 0) Short to GND (D1 = 1)



Table 12.	DB4
D7	Thermal warning 2 active (D7 = 1), $T_J = 140^{\circ}C$
D6	Thermal warning 3 active (D6 = 1), $T_J = 120^{\circ}C$
D5	Channel RR Current Detection Output peak current <250mA - Output load (D5 = 1) Output peak current >500mA - Output load (D5 = 0)
D4	Channel RR Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel R R Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel RR Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel RR No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel RR No short to GND (D1 = 0) Short to GND (D1 = 1)

Table 12. DB4



9 Examples of bytes sequence

1 - Turn-On diagnostic - Write operation

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Start	Address byte with D0 = 0	ACK	IB1 with $D6 = 1$	ACK	IB2	ACK	STOP

2 - Turn-On diagnostic - Read operation

Start Address byte with D0 = 1 ACK DB1 ACK DB2 ACK DB3 ACK DB4 ACK ST												
	Start A	Address byte with D0 = 1	ACK	DB1	ACK	DB2	ACK	DB3	ACK	DB4	ACK	STOP

• The delay from 1 to 2 can be selected by software, starting from 1ms

3a - Turn-On of the power amplifier with 26dB gain, mute on, diagnostic defeat, CD = 2%.

Start	Address byte with D0 = 0	ACK	IB1	ACK	IB2	ACK	STOP
			X0000000		XXX1XX11		

3b - Turn-Off of the power amplifier

Start	Address byte with D0 = 0	ACK	IB1	ACK	IB2	ACK	STOP
			X0XXXXXX		XXX0XXXX		

4 - Offset detection procedure enable

Start	Address byte with D0 = 0	IB1	ACK	ACK IB2		STOP	
			XX1XX11X		XXX1XXXX		

5 - Offset detection procedure stop and reading operation (the results are valid only for the offset detection bits (D2 of the bytes DB1, DB2, DB3, DB4).

Start Address byte with D0 = 1 ACK DB1 ACK DB2 ACK DB3 ACK DB4 ACK STOP												
	Start	Address byte with D0 = 1	ACK	DB1	ACK	DB2	ACK	DB3	ACK	DB4	ACK	STOP

• The purpose of this test is to check if a D.C. offset (2V typ.) is present on the outputs, produced by input capacitor with anomalous leakage current or humidity between pins.

• The delay from 4 to 5 can be selected by software, starting from 1ms



10 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*.

 $ECOPACK^{\mathbb{R}}$ is an ST trademark.

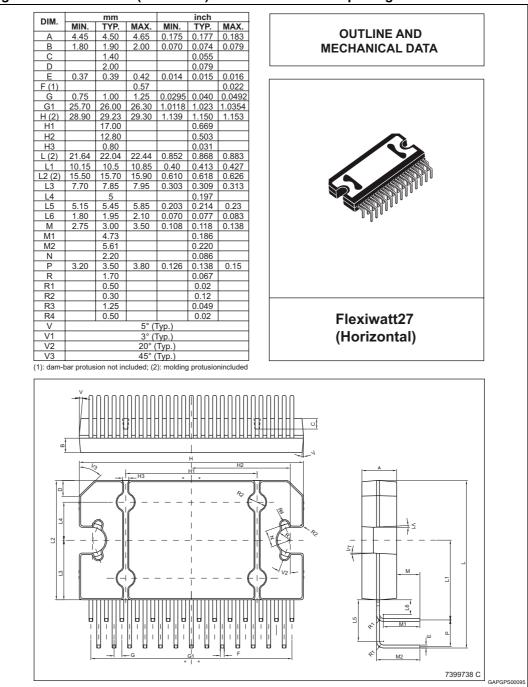


Figure 32. Flexiwatt27 (horizontal) mechanical data and package dimensions

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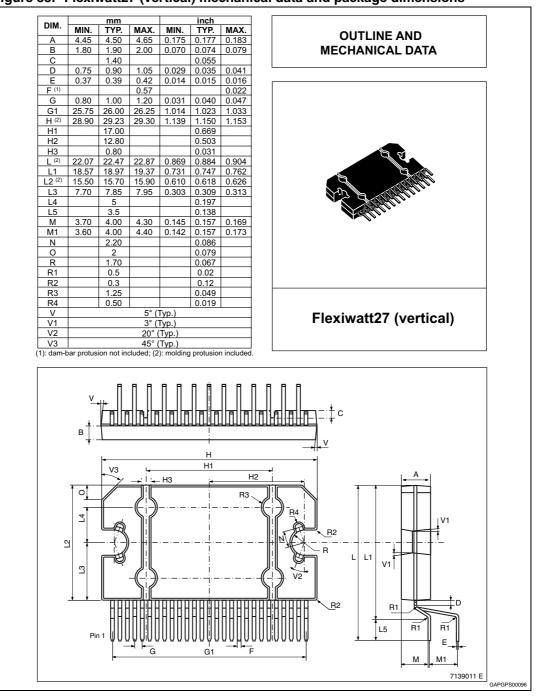


Figure 33. Flexiwatt27 (vertical) mechanical data and package dimensions



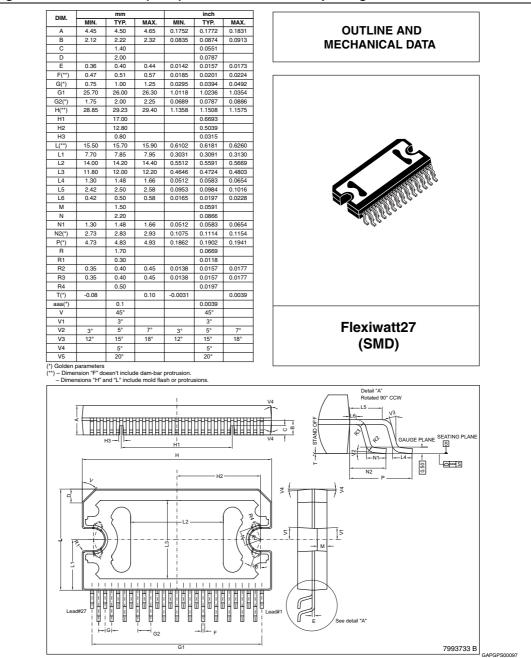
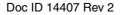


Figure 34. Flexiwatt27 (SMD) mechanical data and package dimensions





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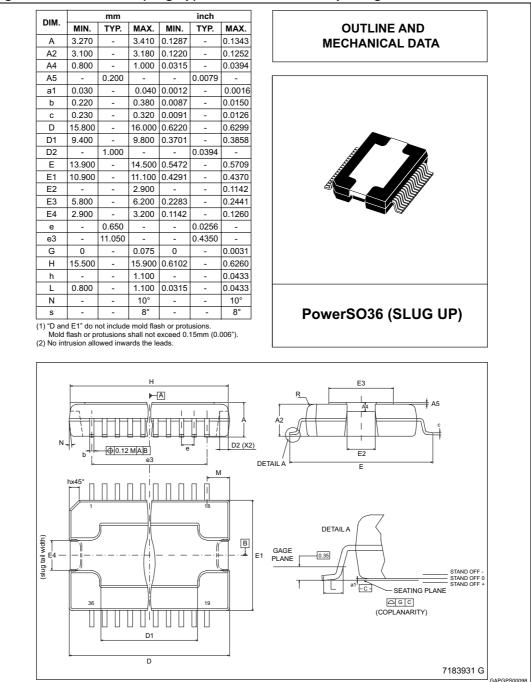


Figure 35. PowerSO36 (slug up) mechanical data and package dimensions

11 Revision history

Table 13. Document revision history

Date	Revision	Changes
07-Feb-2008	1	Initial release.
10-Aug-2012 2		Updated Section 10: Package information.



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